## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10796599	FENG, WEISHI
Examiner	Art Unit
San Juan, Martin Jeriko P	2109

SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES				
Search Notes	Date	Examiner		
Consulted with SPE for initial search strategy (Del Sole, Joseph)	2/26/2007	MJSJ		
EAST Search (see attached).	2/26/2007	MJSJ		
Consulted with Art Unit 2132 for reference quality check (Heneghan, Matthew)	3/01/2007	MJSJ		
Inventor Search, reviewed related applications (see attached)	2/26/2007	MJSJ		

INTERFERENCE SEARCH				
Class	Subclass	Date	Examine	

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